

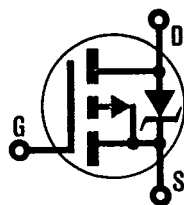
# INTERNATIONAL RECTIFIER



### REPETITIVE AVALANCHE AND $dv/dt$ RATED\*

# HEXFET® TRANSISTORS

**P-CHANNEL  
POWER MOSFETs  
TO-247AC PACKAGE**



IRFP9140

IRFP9141

IRFP9142

IRFP9143

**– 100 Volt, 0.20 Ohm HEXFET  
TO-247AC (TO-3P) Plastic Package**

The HEXFET® technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery dv/dt capability.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

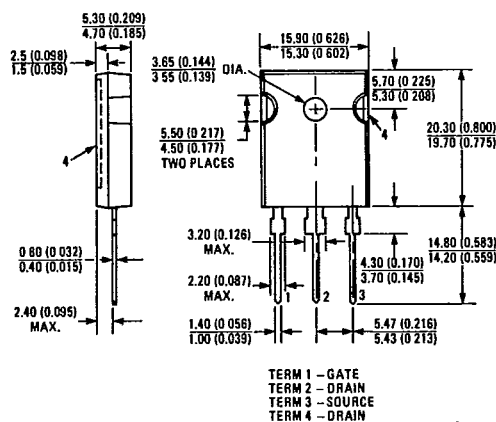
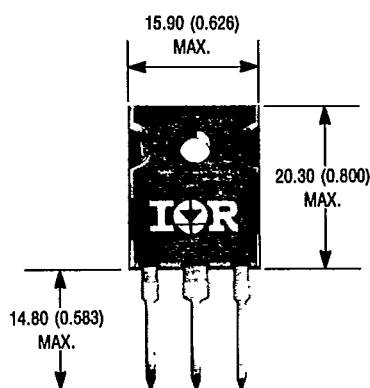
## Product Summary

| Part Number | V <sub>DS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|-------------|-----------------|---------------------|----------------|
| IRFP9140    | −100V           | 0.20Ω               | −19A           |
| IRFP9141    | −60V            | 0.20Ω               | −19A           |
| IRFP9142    | −100V           | 0.30Ω               | −16A           |
| IRFP9143    | −60V            | 0.30Ω               | −16A           |

### Features:

- Isolated Central Mounting Hole
- Rugged Package Design
- Repetitive Avalanche Ratings
- Dynamic  $dv/dt$  Rating
- Simple Drive Requirements
- Ease of Paralleling

## CASE STYLE AND DIMENSIONS



**Conforms to JEDEC Outline TO-247AC (TO-3P)**  
**Dimensions in Millimeters and (Inches)**

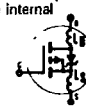
\*This data sheet applies to product with batch codes that begin with a digit, ie. 2A3B

## Absolute Maximum Ratings

| Parameter                                                       | IRFP9140, IRFP9141                        | IRFP9142, IRFP9143 | Units            |
|-----------------------------------------------------------------|-------------------------------------------|--------------------|------------------|
| $I_D$ @ $T_C = 25^\circ\text{C}$ Continuous Drain Current       | -19                                       | -16                | A                |
| $I_D$ @ $T_C = 100^\circ\text{C}$ Continuous Drain Current      | -12                                       | -10                | A                |
| $I_{DM}$ Pulsed Drain Current ①                                 | -76                                       | -64                | A                |
| $P_D$ @ $T_C = 25^\circ\text{C}$ Max. Power Dissipation         | 150                                       |                    | W                |
| Linear Derating Factor                                          | 1.2                                       |                    | W/K ②            |
| $V_{GS}$ Gate-to-Source Voltage                                 | $\pm 20$                                  |                    | V                |
| $E_{AS}$ Single Pulse Avalanche Energy ③                        | 960<br>(See Fig. 14)                      |                    | mJ               |
| $I_{AR}$ Avalanche Current ①<br>(Repetitive or Non-Repetitive)  | -19<br>(See $E_{AR}$ )                    |                    | A                |
| $E_{AR}$ Repetitive Avalanche Energy ①                          | 15<br>(See $I_{AR}$ )                     |                    | mJ               |
| $dv/dt$ Peak Diode Recovery $dv/dt$ ③                           | 5.5<br>(See Fig. 17)                      |                    | V/ns             |
| $T_J$ Operating Junction<br>$T_{STG}$ Storage Temperature Range | -55 to 150                                |                    | $^\circ\text{C}$ |
| Lead Temperature                                                | 300 (0.063 in. (1.6mm) from case for 10s) |                    | $^\circ\text{C}$ |

Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (Unless Otherwise Specified)

| Parameter                                                    | Type                 | Min. | Typ. | Max.          | Units    | Test Conditions                                                                                                                  |
|--------------------------------------------------------------|----------------------|------|------|---------------|----------|----------------------------------------------------------------------------------------------------------------------------------|
| $BV_{DSS}$ Drain-to-Source Breakdown Voltage                 | IRFP9140<br>IRFP9142 | -100 | —    | —             | V        | $V_{GS} = 0V, I_D = -250 \mu A$                                                                                                  |
|                                                              | IRFP9141<br>IRFP9143 | -60  | —    | —             | V        |                                                                                                                                  |
| $R_{DS(on)}$ Static Drain-to-Source<br>On State Resistance ④ | IRFP9140<br>IRFP9141 | —    | 0.14 | 0.20          | $\Omega$ | $V_{GS} = -10V, I_D = -10A$                                                                                                      |
|                                                              | IRFP9142<br>IRFP9143 | —    | 0.20 | 0.30          | $\Omega$ |                                                                                                                                  |
| $I_{D(on)}$ On-State Drain Current ⑤                         | IRFP9140<br>IRFP9141 | -19  | —    | —             | A        | $V_{DS} > I_{D(on)} \times R_{DS(on)}$ Max.<br>$V_{GS} = -10V$                                                                   |
|                                                              | IRFP9142<br>IRFP9143 | -16  | —    | —             | A        |                                                                                                                                  |
| $V_{GS(th)}$ Gate Threshold Voltage                          | ALL                  | -2.0 | —    | -4.0          | V        | $V_{DS} = V_{GS}, I_D = -250 \mu A$                                                                                              |
| $g_{fs}$ Forward Transconductance ⑥                          | ALL                  | 5.3  | 7.9  | —             | S (S)    | $V_{DS} \leq -50V, I_{DS} = -10A$                                                                                                |
| $I_{DSS}$ Zero Gate Voltage Drain Current                    | ALL                  | —    | —    | -250<br>-1000 | $\mu A$  | $V_{DS} = \text{Max. Rating}, V_{GS} = 0V$<br>$V_{DS} = 0.8 \times \text{Max. Rating}$<br>$V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$ Gate-to-Source Leakage Forward                     | ALL                  | —    | —    | -500          | nA       | $V_{GS} = -20V$                                                                                                                  |
| $I_{GSS}$ Gate-to-Source Leakage Reverse                     | ALL                  | —    | —    | 500           | nA       | $V_{GS} = 20V$                                                                                                                   |
| $Q_g$ Total Gate Charge                                      | ALL                  | —    | 37   | 55            | nC       | $V_{GS} = -10V, I_D = -18A$<br>$V_{DS} = 0.8 \times \text{Max. Rating}$<br>See Fig. 16                                           |
| $Q_{gs}$ Gate-to-Source Charge                               | ALL                  | —    | 8.7  | 13            | nC       | (Independent of operating temperature)                                                                                           |
| $Q_{gd}$ Gate-to-Drain ("Miller") Charge                     | ALL                  | —    | 22   | 34            | nC       | (Independent of operating temperature)                                                                                           |
| $t_{d(on)}$ Turn-On Delay Time                               | ALL                  | —    | 12   | 18            | ns       | $V_{DD} = -50V, I_D = -18A, R_G = 9.1\Omega$                                                                                     |
| $t_r$ Rise Time                                              | ALL                  | —    | 67   | 100           | ns       | $R_D = 2.7\Omega$                                                                                                                |
| $t_{d(off)}$ Turn-Off Delay Time                             | ALL                  | —    | 26   | 39            | ns       | See Fig. 15                                                                                                                      |
| $t_f$ Fall Time                                              | ALL                  | —    | 47   | 71            | ns       | (Independent of operating temperature)                                                                                           |
| $L_D$ Internal Drain Inductance                              | ALL                  | —    | 5.0  | —             | nH       | Measured from the drain lead, 6mm (0.25 in.) from package to center of die.                                                      |
| $L_S$ Internal Source Inductance                             | ALL                  | —    | 13   | —             | nH       | Measured from the source lead, 6mm (0.25 in.) from package to source bonding pad.                                                |
| $C_{iss}$ Input Capacitance                                  | ALL                  | —    | 1200 | —             | pF       | $V_{GS} = 0V, V_{DS} = -25V$                                                                                                     |
| $C_{oss}$ Output Capacitance                                 | ALL                  | —    | 570  | —             | pF       | $f = 1.0 \text{ MHz}$                                                                                                            |
| $C_{rss}$ Reverse Transfer Capacitance                       | ALL                  | —    | 160  | —             | pF       | See Fig. 10                                                                                                                      |



## Source-Drain Diode Ratings and Characteristics

| Parameter |                                        | Type | Min.                                                                                             | Typ. | Max. | Units         | Test Conditions                                                                                                                                                    |
|-----------|----------------------------------------|------|--------------------------------------------------------------------------------------------------|------|------|---------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $I_S$     | Continuous Source Current (Body Diode) | ALL  | —                                                                                                | —    | -19  | A             | Modified MOSFET symbol showing the integral Reverse p-n junction rectifier.<br> |
| $I_{SM}$  | Pulsed Source Current (Body Diode) ①   | ALL  | —                                                                                                | —    | -76  | A             |                                                                                                                                                                    |
| $V_{SD}$  | Diode Forward Voltage ④                | ALL  | —                                                                                                | —    | -4.2 | V             | $T_J = 25^{\circ}\text{C}$ , $I_S = -19\text{A}$ , $V_{GS} = 0\text{V}$                                                                                            |
| $t_{rr}$  | Reverse Recovery Time                  | ALL  | 65                                                                                               | 130  | 280  | ns            | $T_J = 25^{\circ}\text{C}$ , $I_F = -18\text{A}$ , $di/dt = 100\text{ A}/\mu\text{s}$                                                                              |
| $Q_{RR}$  | Reverse Recovery Charge                | ALL  | 0.34                                                                                             | 0.73 | 1.6  | $\mu\text{C}$ |                                                                                                                                                                    |
| $t_{on}$  | Forward Turn-On Time                   | ALL  | Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$ . |      |      |               |                                                                                                                                                                    |

## Thermal Resistance

|                                |     |   |      |      |          |                                            |
|--------------------------------|-----|---|------|------|----------|--------------------------------------------|
| $R_{thJC}$ Junction-to-Case    | ALL | — | —    | 0.83 | K/W ⑤    |                                            |
| $R_{thCS}$ Case-to-Sink        | ALL | — | 0.24 | —    | K/W ⑤    | Mounting surface flat, smooth, and greased |
| $R_{thJA}$ Junction-to-Ambient | ALL | — | —    | 40   | K/W ⑤    | Typical socket mount                       |
| Mounting Torque                | ALL | — | —    | 10   | In.·lbs. | Standard 10-32 screw                       |

① Repetitive Rating; Pulse width limited by maximum junction temperature (see figure 5) Refer to current HEXFET reliability report

② @  $V_{DD} = -50\text{V}$ , Starting  $T_J = 25^\circ\text{C}$ ,  $L = 4.2\text{ mH}$ ,  $R_G = 25\Omega$ , Peak  $I_L = -19\text{A}$

③  $I_{SD} = -19\text{A}$ ,  $di/dt = 170\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ ,  $T_J \leq 150^\circ\text{C}$  Suggested  $R_G = 9.1\Omega$

④ Pulse width  $\leq 300\mu\text{s}$ ; Duty Cycle  $\leq 2\%$

⑤  $\text{K/W} = ^\circ\text{C/W}$   
 $\text{W/K} = \text{W}/^\circ\text{C}$

TO-3P

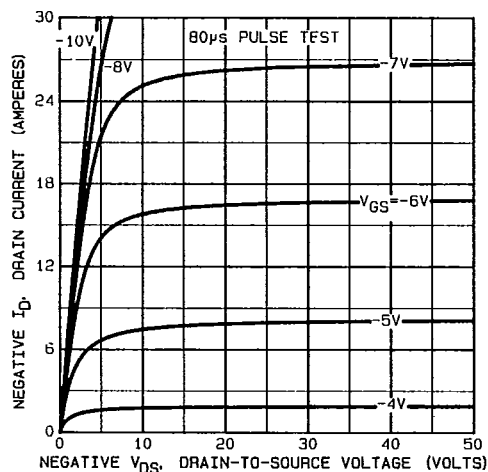


Fig. 1 — Typical Output Characteristics

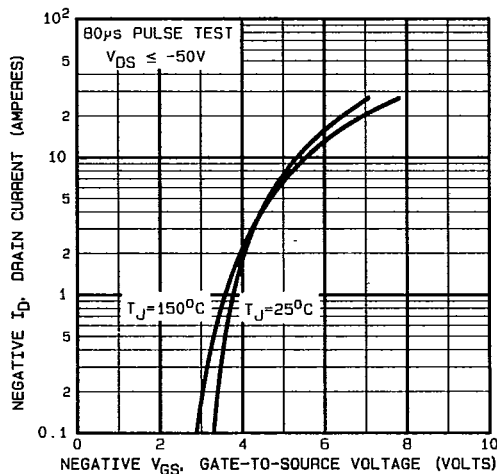


Fig. 2 — Typical Transfer Characteristics

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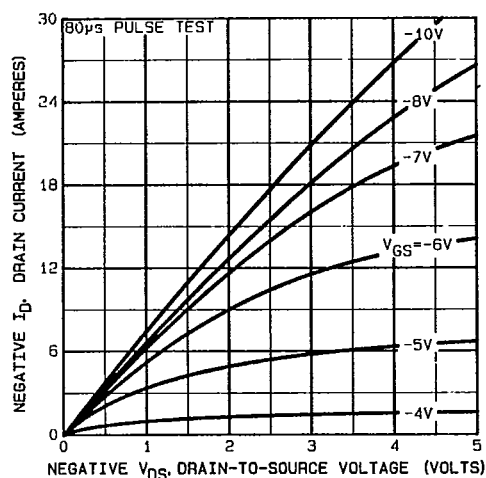


Fig. 3 — Typical Saturation Characteristics

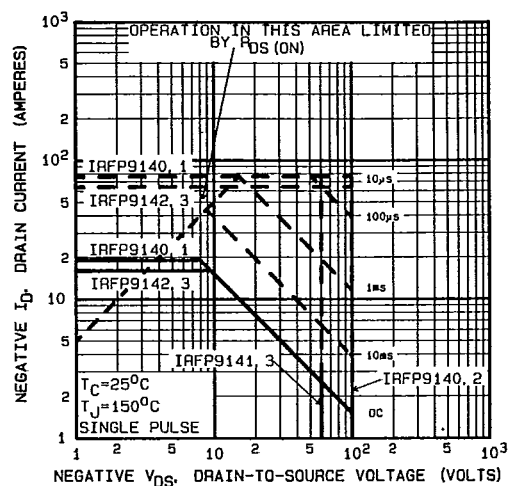


Fig. 4 — Maximum Safe Operating Area

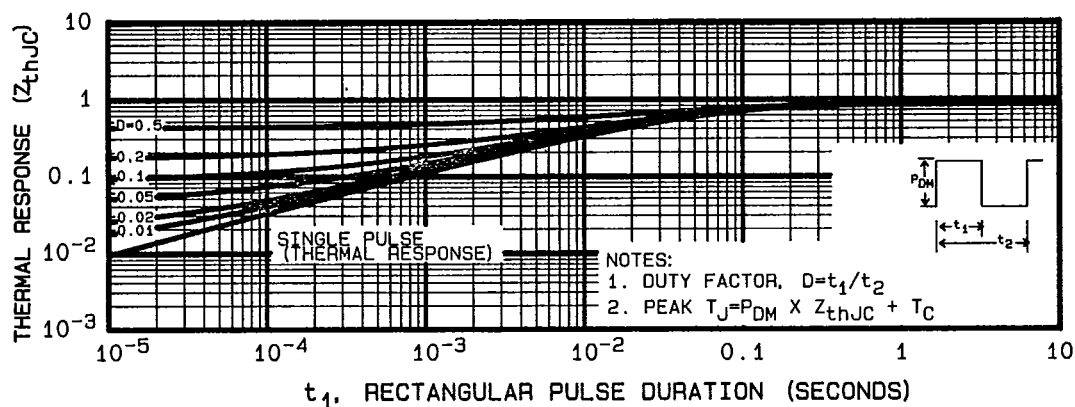


Fig. 5 — Maximum Effective Transient Thermal Impedance, Junction-to Case Vs. Pulse Duration

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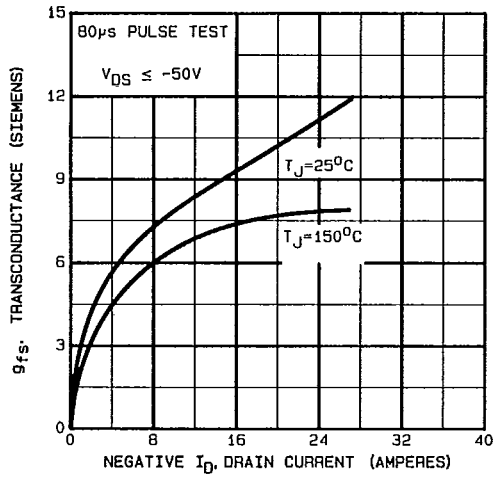


Fig. 6 — Typical Transconductance Vs. Drain Current

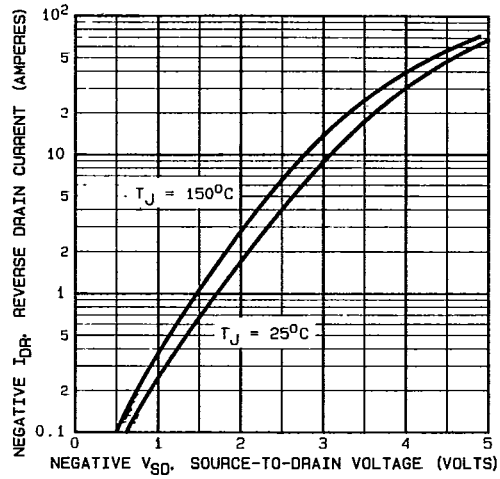


Fig. 7 — Typical Source-Drain Diode Forward Voltage

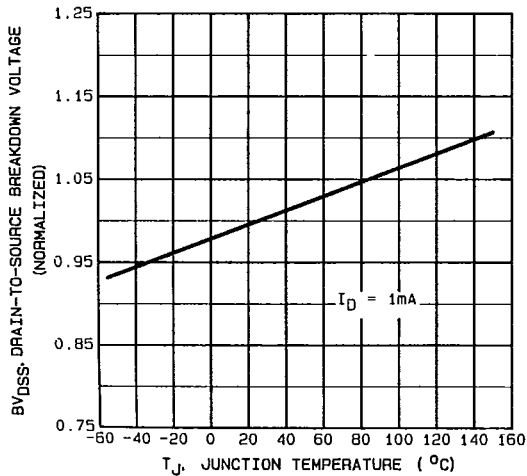


Fig. 8 — Breakdown Voltage Vs. Temperature

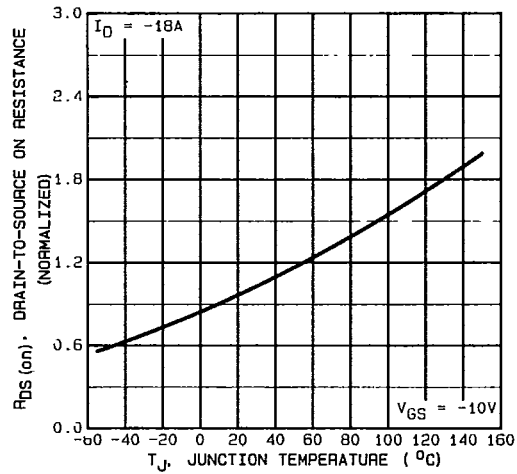


Fig. 9 — Normalized On-Resistance Vs. Temperature

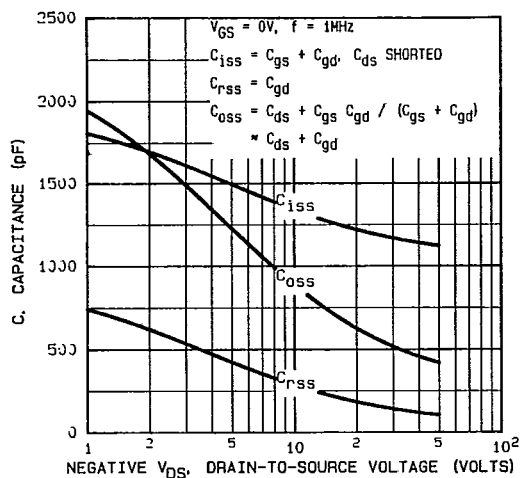


Fig. 10 — Typical Capacitance Vs. Drain-to-Source Voltage

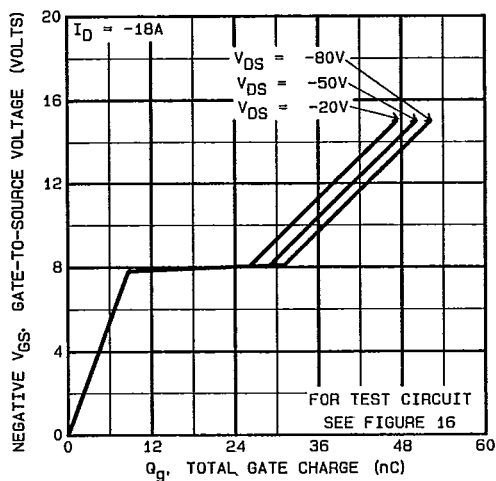


Fig. 11 — Typical Gate Charge Vs. Gate-to-Source Voltage

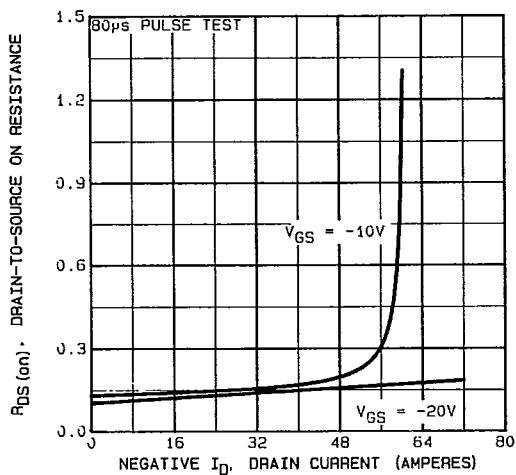


Fig. 12 — Typical On-Resistance Vs. Drain Current

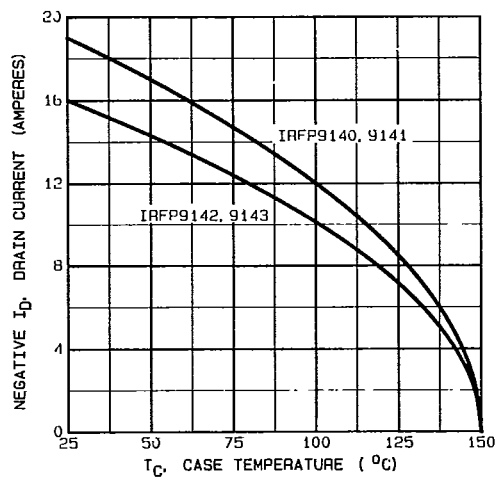


Fig. 13 — Maximum Drain Current Vs. Case Temperature

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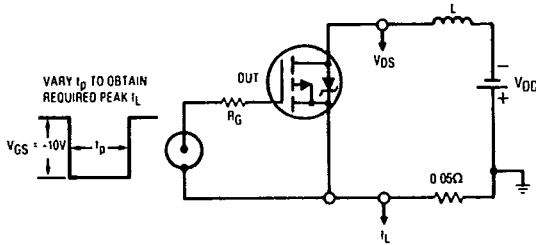


Fig. 14a - Unclamped Inductive Test Circuit

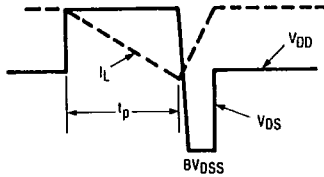


Fig. 14b - Unclamped Inductive Waveforms

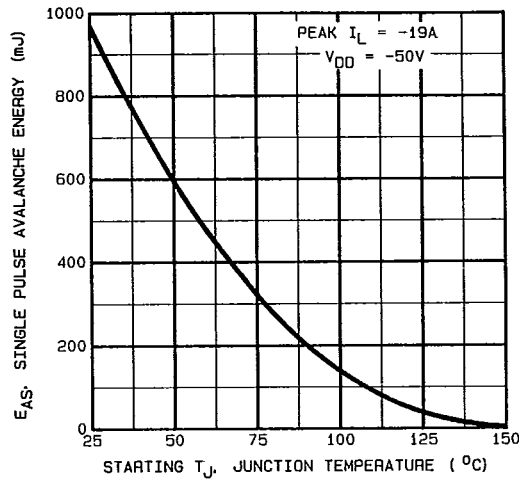


Fig. 14c - Maximum Avalanche Energy Vs. Starting Junction Temperature

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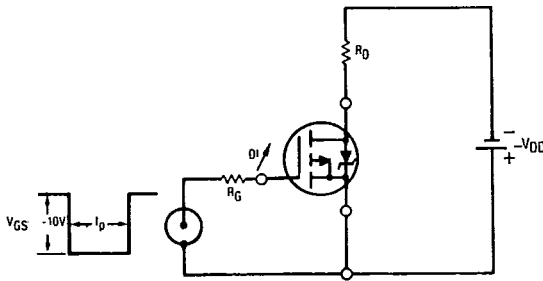


Fig. 15a - Switching Time Test Circuit

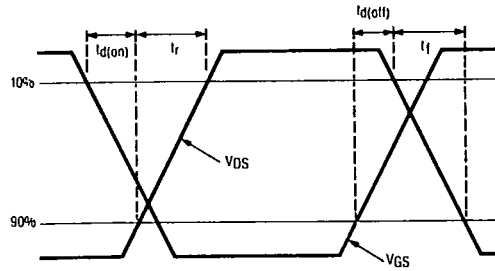


Fig. 15b - Switching Time Waveforms

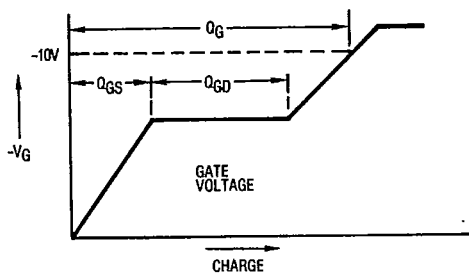


Fig. 16a - Basic Gate Charge Waveform

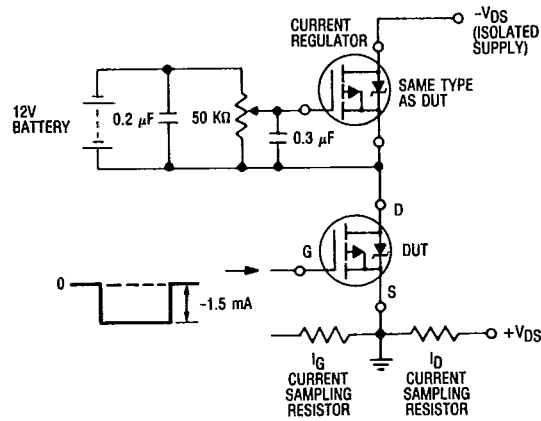


Fig. 16b - Gate Charge Test Circuit

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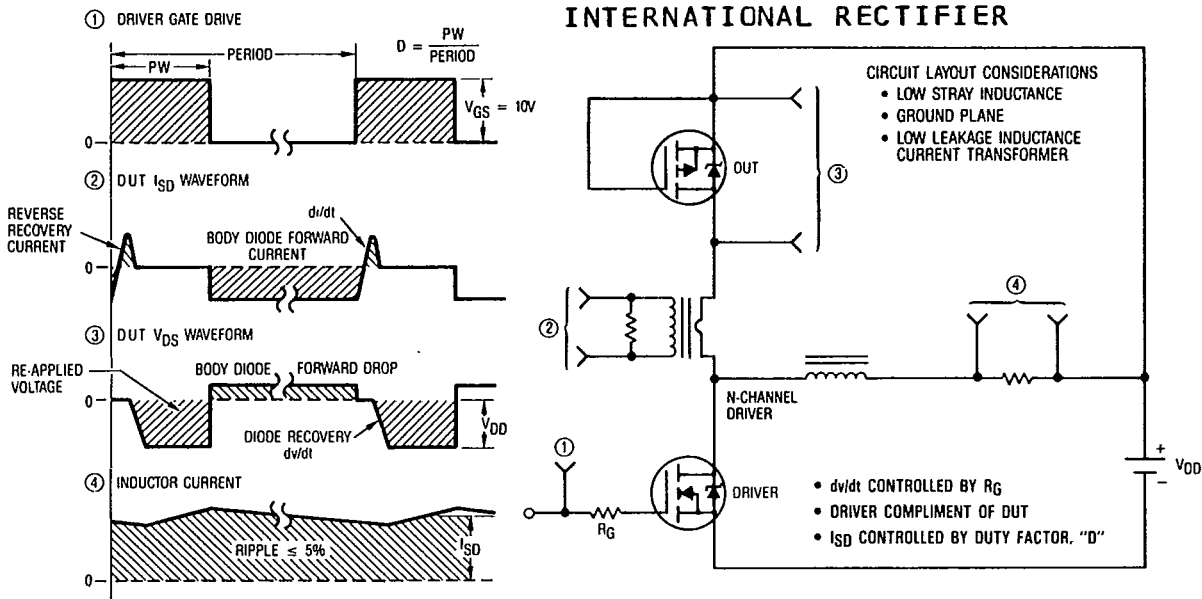


Fig. 17 — Peak Diode Recovery  $dV/dt$  Test Circuit